

<b>Notice of References Cited</b>	Application/Control No. 09/940,083	Applicant(s)/Patent Under Reexamination FELDMAN ET AL.	
	Examiner Bradley B. Bayat	Art Unit 3621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,636,966 B1	10-2003	Lee et al.	713/165
	B	US-2002/0106086 A1	08-2002	Kamiya et al.	380/277
	C	US-6,711,553 B1	03-2004	Deng et al.	705/57
	D	US-6,868,494 B1	03-2005	Shitara et al.	713/189
	E	US-6,359,986 B1	03-2002	Tatebayashi, Makoto	380/277
	F	US-4,386,233	05-1983	Smid et al.	380/281
	G	US-5,337,357	08-1994	Chou et al.	705/56
	H	US-5,912,969	06-1999	Sasamoto et al.	705/57
	I	US-6,098,053	08-2000	Slater, Alan	705/44
	J	US-6,249,866	06-2001	Brundrett et al.	713/165
	K	US-6,471,068	10-2002	Kido et al.	707/103R
	L	US-2003/0169733	09-2003	Gurkowski et al.	370/382
	M	US-2003/0115146	06-2003	Lee et al.	705/57

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.